

flowPIM 2
1200V/35A
Features

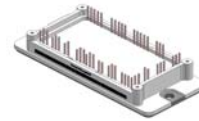
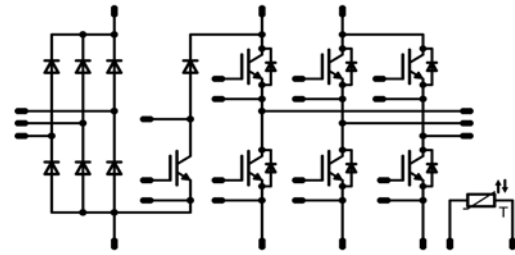
- 3~rectifier, BRC, Inverter, NTC
- Very Compact housing, easy to route
- IGBT4/ EmCon4 technology for low saturation losses and improved EMC behavior

Target Applications

- Motor Drives
- Power Generation

Types

- V23990-P767-A-PM

flowPIM2 housing

Schematic


Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Input Rectifier Diode				
Repetitive peak reverse voltage	V_{RRM}		1600	V
Forward current per diode	I_{FAV}	DC current $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	40	A
Surge forward current	I_{FSM}	$t_p=10\text{ms}$ $T_j=25^\circ\text{C}$	400	A
I^2t -value	I^2t		800	A2s
Power dissipation per Diode	P_{tot}	$T_j=T_{jmax}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	58	W
Maximum junction temperature	T_{jmax}		150	$^\circ\text{C}$
Transistor Inverter				
Collector-emitter break down voltage	V_{CE}		1200	V
DC collector current	I_c	$T_j=T_{jmax}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	39	A
Repetitive peak collector current	I_{cpuls}	t_p limited by T_{jmax}	105	A
Power dissipation per IGBT	P_{tot}	$T_j=T_{jmax}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	112	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings*	t_{SC}	$T_j \leq 150^\circ\text{C}$	10	μs
	V_{CC}	VCC	800	V
Maximum junction temperature	T_{jmax}		175	$^\circ\text{C}$

* It is recommended to not exceed 1000 short circuit situations in the lifetime of the module and to allow at least 1s between short circuits

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Diode Inverter				
Peak Repetitive Reverse Voltage	V_{RRM}		1200	V
DC forward current	I_F	$T_j = T_{jmax}$ $T_h = 80^\circ C$ $T_c = 80^\circ C$	40	A
Repetitive peak forward current	I_{FRM}	tp limited by T_{jmax}	70	A
Power dissipation per Diode	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ C$ $T_c = 80^\circ C$	83	W
Maximum junction temperature	T_{jmax}		175	$^\circ C$

Transistor BRC

Collector-emitter break down voltage	V_{CE}		1200	V
DC collector current	I_C	$T_j = T_{jmax}$ $T_h = 80^\circ C$ $T_c = 80^\circ C$	34	A
Repetitive peak collector current	I_{cpuls}	tp limited by T_{jmax} $T_h = 80^\circ C$	75	A
Power dissipation per IGBT	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ C$ $T_c = 80^\circ C$	109	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings*	t_{SC}	$T_j \leq 150^\circ C$	10	μs
	V_{CC}	VCC	800	V
Maximum junction temperature	T_{jmax}		175	$^\circ C$

* It is recommended to not exceed 1000 short circuit situations in the lifetime of the module and to allow at least 1s between short circuits

BRC inverse diode

Peak Repetitive Reverse Voltage	V_{RRM}		1200	V
DC forward current	I_F	$T_j = T_{jmax}$ $T_h = 80^\circ C$ $T_c = 80^\circ C$	40	A
Repetitive peak forward current	I_{FRM}	tp limited by T_{jmax} $T_h = 80^\circ C$	400	A
Power dissipation per Diode	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ C$ $T_c = 80^\circ C$	37	W
Maximum junction temperature	T_{jmax}		175	$^\circ C$

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Diode BRC				
Peak Repetitive Reverse Voltage	V_{RRM}		1200	V
DC forward current	I_F	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$ $T_c = 80^\circ\text{C}$	30	A
Repetitive peak forward current	I_{FRM}	tp limited by T_{jmax} $T_h = 80^\circ\text{C}$	50	A
Power dissipation per Diode	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$ $T_c = 80^\circ\text{C}$	62	W
Maximum junction temperature	T_{jmax}		175	$^\circ\text{C}$

Thermal properties

Storage temperature	T_{stg}		-40...+125	$^\circ\text{C}$
Operation temperature	T_{op}		-40...+150	$^\circ\text{C}$

Insulation properties

Insulation voltage	V_{is}	t=1min	4000	Vdc
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm

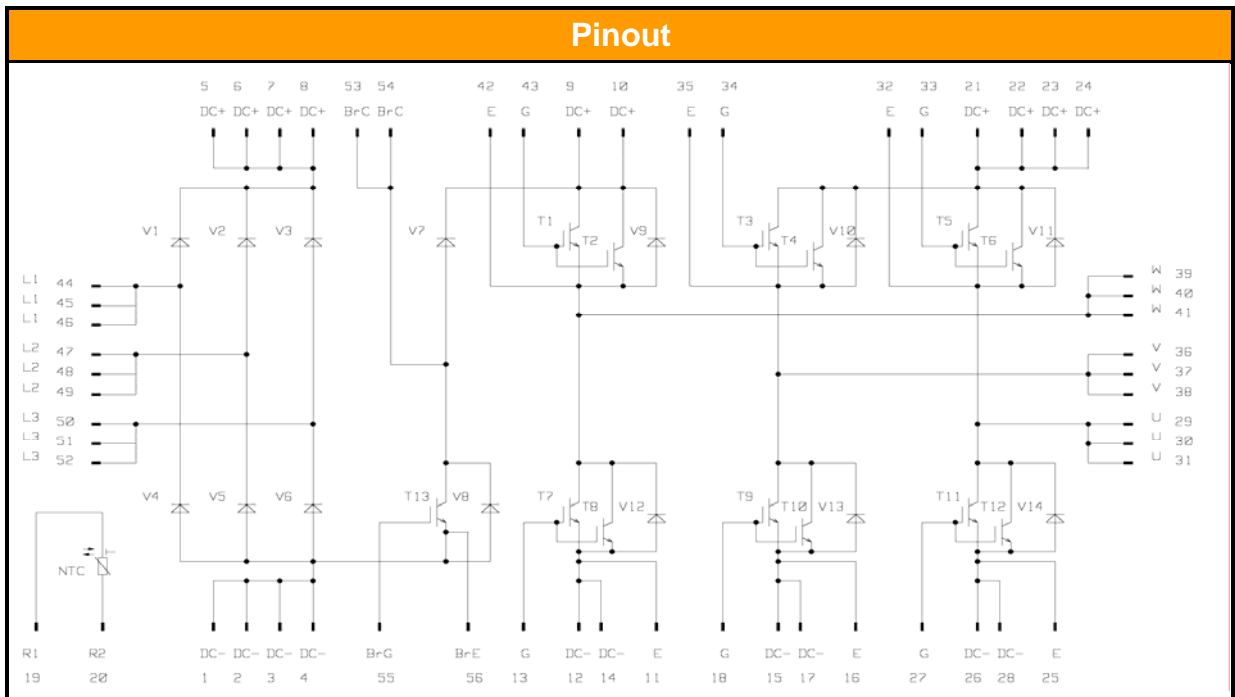
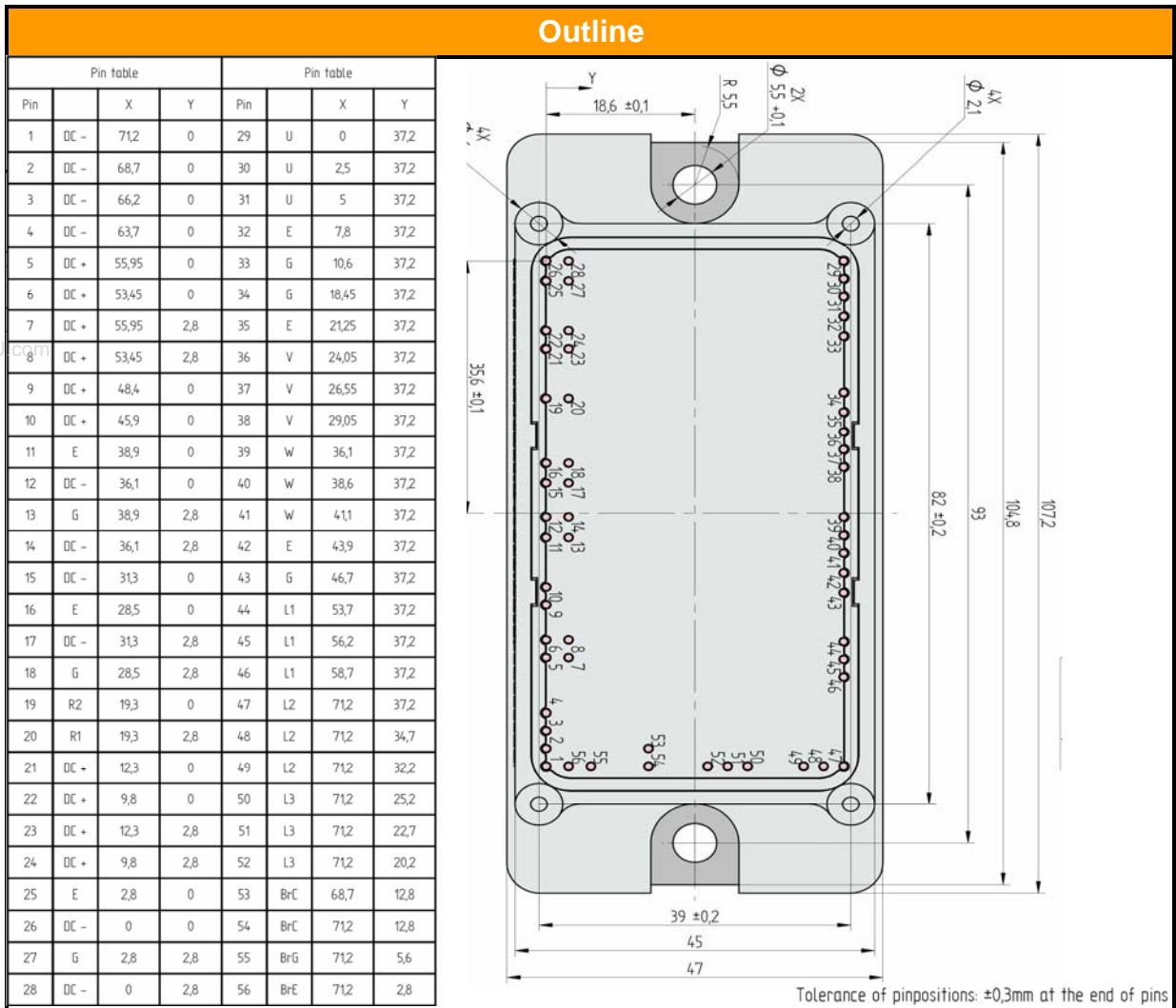
Characteristic Values

Parameter	Symbol	Conditions				Value			Unit	
		$V_{GE}(V)$ or $V_{GS}(V)$	$V_c(V)$ or $V_{CE}(V)$ or $V_{DS}(V)$	$I_c(A)$ or $I_e(A)$ or $I_b(A)$	$T(^{\circ}C)$	Min	Typ	Max		
Input Rectifier Bridge										
Forward voltage	V_F			25	$T_J=25^{\circ}C$ $T_J=125^{\circ}C$	1 0,9	1,21 1,1		V	
Threshold voltage (for power loss calc. only)	V_{th}				$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		0,83		V	
Slope resistance (for power loss calc. only)	r_t				$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		0,0066		Ohm	
Reverse leakage current	I_r		1600		$T_J=25^{\circ}C$ $T_J=145^{\circ}C$		0,05 1,1		mA	
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness \leq 50um $\lambda = 0,61$ W/mK				1,20			K/W	
Thermal resistance chip to case per chip	R_{thJC}									
Transistor Inverter										
Gate emitter threshold voltage	$V_{GE(th)}$	VCE=VGE			0,0012	$T_J=25^{\circ}C$ $T_J=125^{\circ}C$	5 5,8	6,5	V	
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		35	$T_J=25^{\circ}C$ $T_J=125^{\circ}C$	1,6	1,85	2,1	V
Collector-emitter cut-off	I_{CES}		0	1200		$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		0,005	mA	
Gate-emitter leakage current	I_{GES}		20	0		$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		120	nA	
Integrated Gate resistor	R_{gint}								Ohm	
Turn-on delay time	$t_{d(on)}$	$R_g=tb_d \Omega$				$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d	ns	
Rise time	t_r					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d	ns	
Turn-off delay time	$t_{d(off)}$					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d	ns	
Fall time	t_f					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d	ns	
Turn-on energy loss per pulse	E_{on}					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d	mWs	
Turn-off energy loss per pulse	E_{off}					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d	mWs	
Input capacitance	C_{ies}							1,95		nF
Output capacitance	C_{oss}	f=1MHz	0	25		$T_J=25^{\circ}C$	0,155		nF	
Reverse transfer capacitance	C_{rss}						0,115		nF	
Gate charge	Q_{Gate}		± 15			$T_J=25^{\circ}C$	tb_d		nC	
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness \leq 50um $\lambda = 0,61$ W/mK					0,77		K/W	
Thermal resistance chip to case per chip	R_{thJC}								K/W	
Diode Inverter										
Diode forward voltage	V_F				35	$T_J=25^{\circ}C$ $T_J=125^{\circ}C$	1,35	1,7	2,05	V
Reverse leakage current	I_{rm}					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$			7,7	mA
Peak reverse recovery current	I_{RRM}	tb_d				$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d		A
Reverse recovery time	t_{rr}					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d		ns
Reverse recovery charge	Q_{rr}					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d		mC
Peak rate of fall of reverse recovery current	$di(rec)_{max}/dt$							tb_d		A/ms
Reverse recovery energy	E_{rec}					$T_J=25^{\circ}C$ $T_J=125^{\circ}C$		tb_d		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}		Thermal grease thickness \leq 50um $\lambda = 0,61$ W/mK					1,07		K/W
Thermal resistance chip to case per chip	R_{thJC}								K/W	

Characteristic Values

Parameter	Symbol	Conditions				Value			Unit					
		$V_{GE}(V)$ or $V_{GS}(V)$	$V_r(V)$ or $V_{CE}(V)$ or $V_{DS}(V)$	$I_c(A)$ or $I_e(A)$ or $I_b(A)$	T(°C)	Min	Typ	Max						
Transistor BRC														
Gate emitter threshold voltage	$V_{GE(th)}$	VCE=VGE			0,00085	T _J =25°C T _J =125°C	5	5,8	6,5	V				
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		25	T _J =25°C T _J =125°C	1,6	1,85	2,1	V				
Collector-emitter cut-off	I_{CES}		0	1200		T _J =25°C T _J =125°C			0,0024	mA				
Gate-emitter leakage current	I_{GES}		20	0		T _J =25°C T _J =125°C			120	nA				
Integrated Gate resistor	R_{gint}							-		Ohm				
Turn-on delay time	$t_{d(on)}$	R=tbdΩ				T _J =25°C T _J =125°C		tbid		ns				
Rise time	t_r					T _J =25°C T _J =125°C		tbid		ns				
Turn-off delay time	$t_{d(off)}$					T _J =25°C T _J =125°C		tbid		ns				
Fall time	t_f					T _J =25°C T _J =125°C		tbid		ns				
Turn-on energy loss per pulse	E_{on}					T _J =25°C T _J =125°C				tbid				mWs
Turn-off energy loss per pulse	E_{off}					T _J =25°C T _J =125°C				tbid				mWs
Input capacitance	C_{ies}					f=1MHz	0	25		T _J =25°C		1,43		nF
Output capacitance	C_{oss}		0,115		nF									
Reverse transfer capacitance	C_{iss}		0,085		nF									
Gate charge	Q_{Gate}		15			T _J =25°C		tbid		nC				
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um						0,87		K/W				
Thermal resistance chip to case per chip	R_{thJC}	λ = 0,61 W/mK								K/W				
BRC inverse diode														
Diode forward voltage	V_F				10	T _J =25°C T _J =125°C		tbid tbid		V				
Reverse leakage current	I_r			600		T _J =25°C T _J =125°C		tbid		uA				
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal foil thickness=76um						1,87		K/W				
Thermal resistance chip to case per chip	R_{thJC}	Kunze foil KU-ALF5								K/W				
Diode BRC														
Diode forward voltage	V_F				25	T _J =25°C T _J =125°C	1,35	1,7	2,05	V				
Reverse leakage current	I_r									mA				
Peak reverse recovery current	I_{RRM}	Rgon=tbid Ω Rgon=tbid Ω				T _J =25°C T _J =125°C		tbid tbid		A				
Reverse recovery time	t_{rr}					T _J =25°C T _J =125°C		tbid tbid		ns				
Reverse recovered charge	Q_{rr}					T _J =25°C T _J =125°C		tbid tbid		mC				
Peak rate of fall of reverse recovery current	$di(rec)max/dt$							tbid		A/ms				
Reverse recovery energy	E_{rec}					T _J =25°C T _J =125°C				tbid tbid				mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal foil thickness=76um						1,53		K/W				
Thermal resistance chip to case per chip	R_{thJC}									K/W				
NTC Thermistor														
Rated resistance	R_{25}	Tol. ±5%				T _J =25°C	20,9	22	23,1	kOhm				
Deviation of R100	D_{RR}	R100=1503Ω				T _c =100°C		2,9		%/K				
Power dissipation given Epcos-Type	P					T _J =25°C		210		mW				
B-value	$B_{(25/100)}$	Tol. ±3%				T _J =25°C		3980		K				

Package Outline and Pinout



PRODUCT STATUS DEFINITIONS

Datasheet Status	Product Status	Definition
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